

## The RF Sub-Micron MOSFET Line RF Power Field Effect Transistors N-Channel Enhancement-Mode Lateral MOSFETs

Designed for PCN and PCS base station applications with frequencies from 1.9 to 2.0 GHz. Suitable for TDMA, CDMA and multicarrier amplifier applications.

- Typical 2-Carrier N-CDMA Performance for  $V_{DD} = 26$  Volts,  $I_{DQ} = 1300$  mA,  $f_1 = 1958.75$  MHz,  $f_2 = 1961.25$  MHz IS-95 CDMA (Pilot, Sync, Paging, Traffic Codes 8 Through 13)

1.2288 MHz Channel Bandwidth Carrier. Adjacent Channels Measured over a 30 kHz Bandwidth at  $f_1 - 885$  kHz and  $f_2 + 885$  kHz. Distortion Products Measured over 1.2288 MHz Bandwidth at  $f_1 - 2.5$  MHz and  $f_2 + 2.5$  MHz. Peak/Avg. = 9.8 dB @ 0.01% Probability on CCDF.

Output Power — 24 Watts Avg.

Power Gain — 13.6 dB

Efficiency — 22%

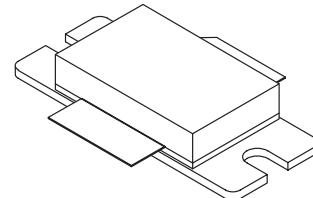
ACPR — -51 dB

IM3 — -37.0 dBc

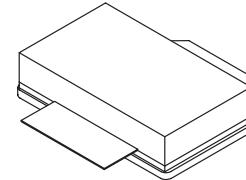
- Internally Matched, Controlled Q, for Ease of Use
- High Gain, High Efficiency and High Linearity
- Integrated ESD Protection
- Designed for Maximum Gain and Insertion Phase Flatness
- Capable of Handling 5:1 VSWR, @ 26 Vdc, 1990 MHz, 125 Watts (CW) Output Power
- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Available in Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.

**MRF19125**  
**MRF19125S**  
**MRF19125SR3**

**1990 MHz, 125 W, 26 V  
LATERAL N-CHANNEL  
RF POWER MOSFETs**



CASE 465B-03, STYLE 1  
(NI-880)  
(MRF19125)



CASE 465C-02, STYLE 1  
(NI-880S)  
(MRF19125S)

### MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	65	Vdc
Gate-Source Voltage	$V_{GS}$	+15, -0.5	Vdc
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	330 1.89	Watts W/ $^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	-65 to +200	$^\circ\text{C}$
Operating Junction Temperature	$T_J$	200	$^\circ\text{C}$

### ESD PROTECTION CHARACTERISTICS

Test Conditions	Class
Human Body Model	2 (Minimum)
Machine Model	M3 (Minimum)

### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.53	$^\circ\text{C/W}$

NOTE – **CAUTION** – MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

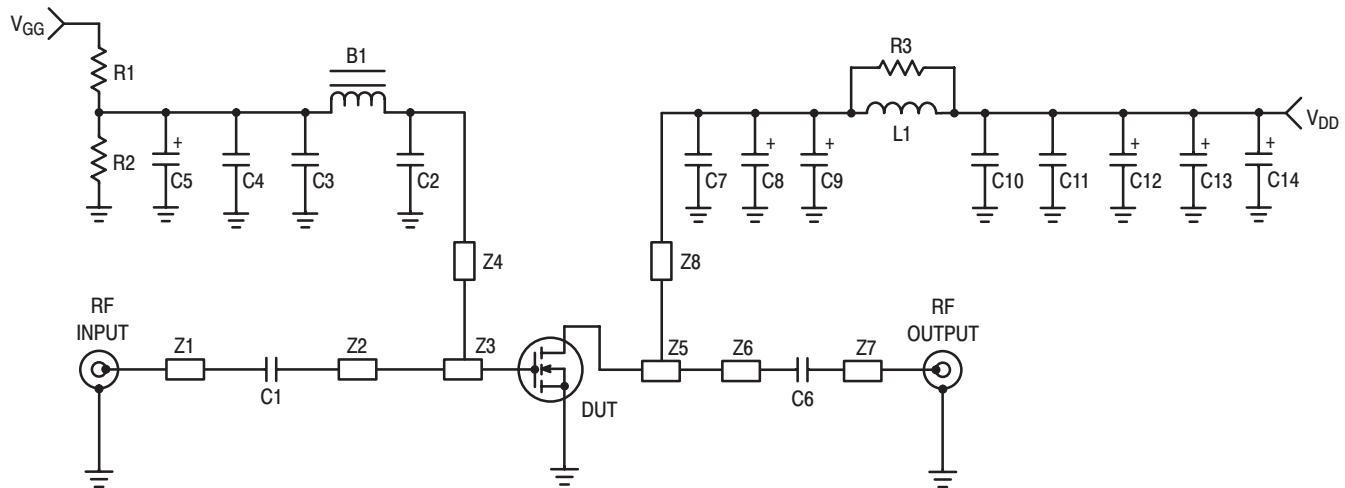
**ELECTRICAL CHARACTERISTICS** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>					
Drain–Source Breakdown Voltage ( $V_{GS} = 0 \text{ Vdc}$ , $I_D = 100 \mu\text{A}\text{dc}$ )	$V_{(BR)DSS}$	65	—	—	Vdc
Gate–Source Leakage Current ( $V_{GS} = 5 \text{ Vdc}$ , $V_{DS} = 0 \text{ Vdc}$ )	$I_{GSS}$	—	—	1	$\mu\text{A}\text{dc}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 26 \text{ Vdc}$ , $V_{GS} = 0 \text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{A}\text{dc}$
<b>ON CHARACTERISTICS</b>					
Forward Transconductance ( $V_{DS} = 10 \text{ Vdc}$ , $I_D = 3 \text{ A}\text{dc}$ )	$g_{fs}$	—	9	—	S
Gate Threshold Voltage ( $V_{DS} = 10 \text{ Vdc}$ , $I_D = 300 \mu\text{A}\text{dc}$ )	$V_{GS(\text{th})}$	2	—	4	Vdc
Gate Quiescent Voltage ( $V_{DS} = 26 \text{ Vdc}$ , $I_D = 1300 \text{ mA}\text{dc}$ )	$V_{GS(Q)}$	2.5	3.9	4.5	Vdc
Drain–Source On–Voltage ( $V_{GS} = 10 \text{ Vdc}$ , $I_D = 3 \text{ A}\text{dc}$ )	$V_{DS(\text{on})}$	—	0.185	0.21	Vdc
<b>DYNAMIC CHARACTERISTICS</b>					
Reverse Transfer Capacitance (1) ( $V_{DS} = 26 \text{ Vdc}$ , $V_{GS} = 0$ , $f = 1 \text{ MHz}$ )	$C_{rss}$	—	5.4	—	pF
<b>FUNCTIONAL TESTS</b> (In Motorola Test Fixture) 2–Carrier N–CDMA, 1.2288 MHz Channel Bandwidth Carriers. Peak/Avg = 9.8 dB @ 0.01% Probability on CCDF.					
Common–Source Amplifier Power Gain ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 24 \text{ W Avg}$ , $I_{DQ} = 1300 \text{ mA}$ , $f_1 = 1930 \text{ MHz}$ , $f_2 = 1932.5 \text{ MHz}$ and $f_1 = 1987.5 \text{ MHz}$ , $f_2 = 1990 \text{ MHz}$ )	$G_{ps}$	12	13.5	—	dB
Drain Efficiency ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 24 \text{ W Avg}$ , $I_{DQ} = 1300 \text{ mA}$ , $f_1 = 1930 \text{ MHz}$ , $f_2 = 1932.5 \text{ MHz}$ and $f_1 = 1987.5 \text{ MHz}$ , $f_2 = 1990 \text{ MHz}$ )	$\eta$	19	22	—	%
Intermodulation Distortion ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 24 \text{ W Avg}$ , $I_{DQ} = 1300 \text{ mA}$ , $f_1 = 1930 \text{ MHz}$ , $f_2 = 1932.5 \text{ MHz}$ and $f_1 = 1987.5 \text{ MHz}$ , $f_2 = 1990 \text{ MHz}$ ; IM3 measured over 1.2288 MHz Bandwidth at $f_1 - 2.5 \text{ MHz}$ and $f_2 + 2.5 \text{ MHz}$ )	IMD	—	-37	-35	dBc
Adjacent Channel Power Ratio ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 24 \text{ W Avg}$ , $I_{DQ} = 1300 \text{ mA}$ , $f_1 = 1930 \text{ MHz}$ , $f_2 = 1932.5 \text{ MHz}$ and $f_1 = 1987.5 \text{ MHz}$ , $f_2 = 1990 \text{ MHz}$ ; ACPR measured over 30 kHz Bandwidth at $f_1 - 885 \text{ MHz}$ and $f_2 + 885 \text{ MHz}$ )	ACPR	—	-51	-47	dBc
Input Return Loss ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 24 \text{ W Avg}$ , $I_{DQ} = 1300 \text{ mA}$ , $f_1 = 1930 \text{ MHz}$ , $f_2 = 1932.5 \text{ MHz}$ and $f_1 = 1987.5 \text{ MHz}$ , $f_2 = 1990 \text{ MHz}$ )	IRL	—	-13	-9	dB
Output Mismatch Stress ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 125 \text{ W CW}$ , $I_{DQ} = 1300 \text{ mA}$ , $f = 1930 \text{ MHz}$ , VSWR = 5:1, All Phase Angles at Frequency of Test)	$\Psi$	No Degradation In Output Power Before and After Test			

(1) Part is internally matched both on input and output.

**ELECTRICAL CHARACTERISTICS — continued** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>FUNCTIONAL TESTS</b> (In Motorola Test Fixture)					
Two-Tone Common-Source Amplifier Power Gain ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 125 \text{ W PEP}$ , $I_{DQ} = 1300 \text{ mA}$ , $f_1 = 1930 \text{ MHz}$ , $f_2 = 1990 \text{ MHz}$ , Tone Spacing = 100 kHz)	$G_{ps}$	—	13.5	—	dB
Two-Tone Drain Efficiency ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 125 \text{ W PEP}$ , $I_{DQ} = 1300 \text{ mA}$ , $f_1 = 1930 \text{ MHz}$ , $f_2 = 1990 \text{ MHz}$ , Tone Spacing = 100 kHz)	$\eta$	—	35	—	%
Third Order Intermodulation Distortion ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 125 \text{ W PEP}$ , $I_{DQ} = 1300 \text{ mA}$ , $f_1 = 1930 \text{ MHz}$ , $f_2 = 1990 \text{ MHz}$ , Tone Spacing = 100 kHz)	IMD	—	-30	—	dBc
Input Return Loss ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 125 \text{ W PEP}$ , $I_{DQ} = 1300 \text{ mA}$ , $f_1 = 1930 \text{ MHz}$ , $f_2 = 1990 \text{ MHz}$ , Tone Spacing = 100 kHz)	IRL	—	-13	—	dB
$P_{out}$ , 1 dB Compression Point ( $V_{DD} = 26 \text{ Vdc}$ , $I_{DQ} = 1300 \text{ mA}$ , $f = 1990 \text{ MHz}$ )	$P_{1dB}$	—	130	—	W



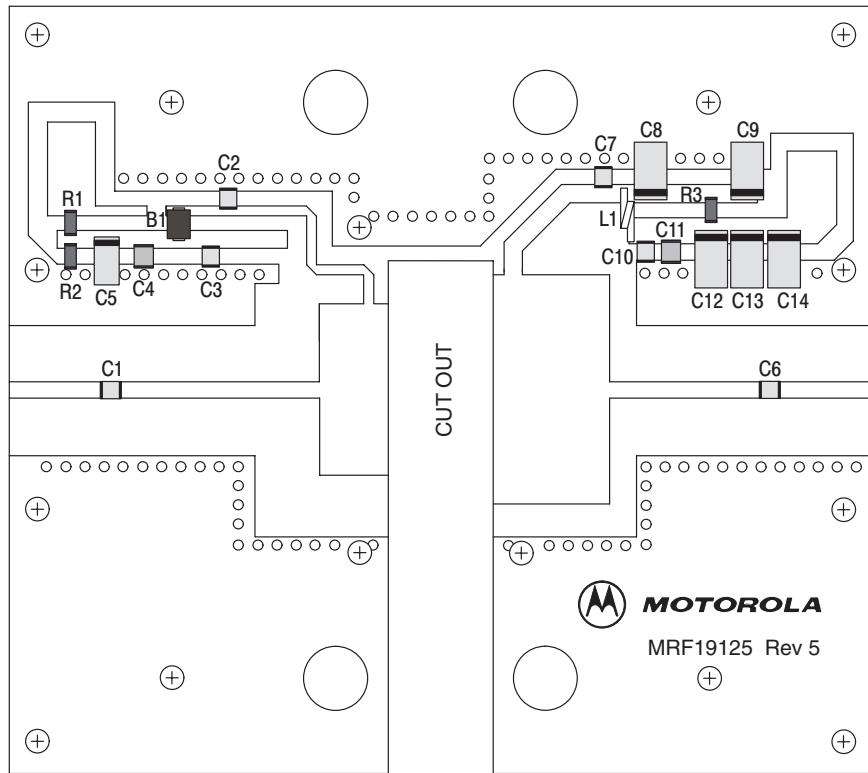
Z1, Z7      0.500" x 0.084" Microstrip  
 Z2      1.105" x 0.084" Microstrip  
 Z3      0.360" x 0.895" Microstrip  
 Z4      0.920" x 0.048" Microstrip  
 Z5      0.605" x 1.195" Microstrip  
 Z6      0.800" x 0.084" Microstrip  
 Z8      0.660" x 0.095" Microstrip

Board      0.030" Glass Teflon®,  
 Keene GX-0300-55-22,  $\epsilon_r = 2.55$   
 PCB      Etched Circuit Boards  
 MRF19125 Rev. 5, CMR

**Figure 1. MRF19125 Test Circuit Schematic**

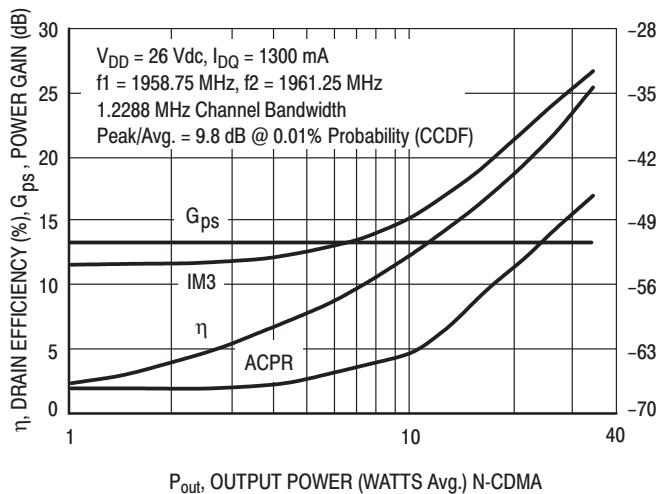
**Table 1. MRF19125 Test Circuit Component Designations and Values**

Designators	Description
B1	Short Ferrite Bead, Fair Rite #2743019447
C1	51 pF Chip Capacitor, ATC #100B510JCA500X
C2, C7	5.1 pF Chip Capacitors, ATC #100B5R1JCA500X
C3, C10	1000 pF Chip Capacitors, ATC #100B102JCA500X
C4, C11	0.1 $\mu$ F Chip Capacitors, Kemet #CDR33BX104AKWS
C5	0.1 $\mu$ F Tantalum Chip Capacitor, Kemet #T491C105M050
C6	10 pF Chip Capacitor, ATC #100B100JCA500X
C8	10 $\mu$ F Tantalum Chip Capacitor, Kemet #T491X106K035AS4394
C9, C12, C13, C14	22 $\mu$ F Tantalum Chip Capacitors, Kemet #T491X226K035AS4394
L1	1 Turn, #20 AWG, 0.100" ID, Motorola
N1, N2	Type N Flange Mounts, Omni Spectra #3052-1648-10
R1	1.0 k $\Omega$ , 1/8 W Chip Resistor
R2	220 k $\Omega$ , 1/8 W Chip Resistor
R3	10 $\Omega$ , 1/8 W Chip Resistor

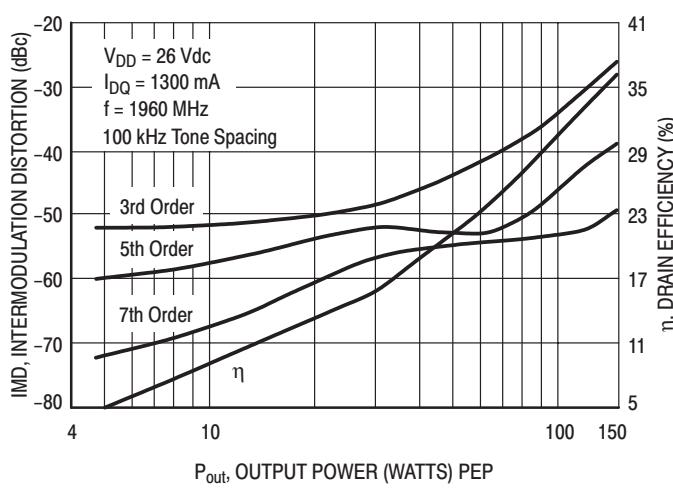


**Figure 2. MRF19125 Test Circuit Component Layout**

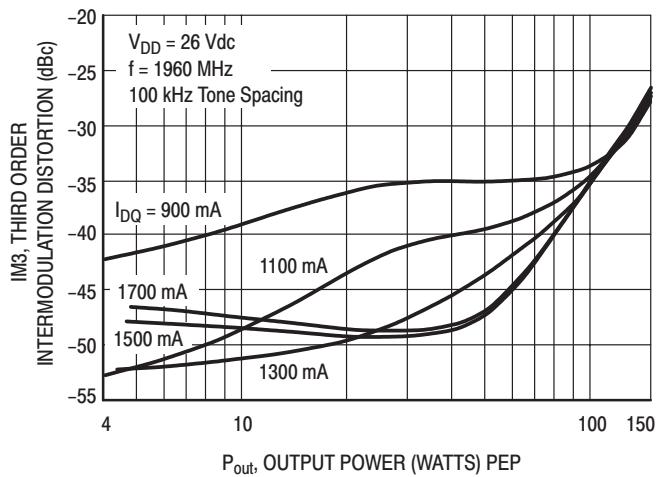
## TYPICAL CHARACTERISTICS



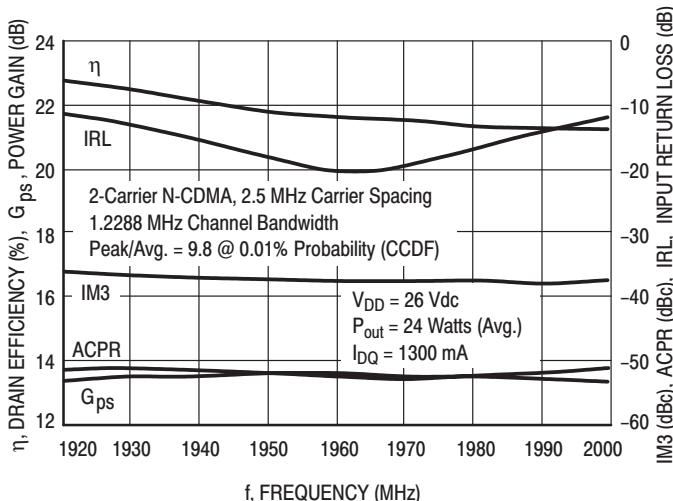
**Figure 3.** 2-Carrier CDMA ACPR, IM3, Power Gain and Drain Efficiency versus Output Power



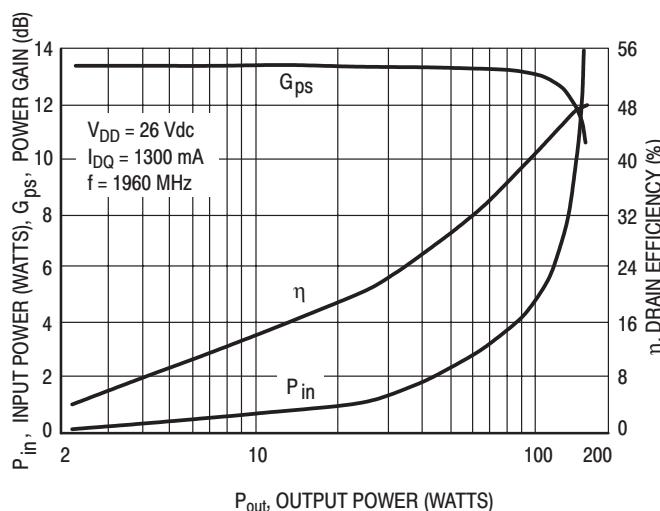
**Figure 4.** Intermodulation Distortion Products versus Output Power



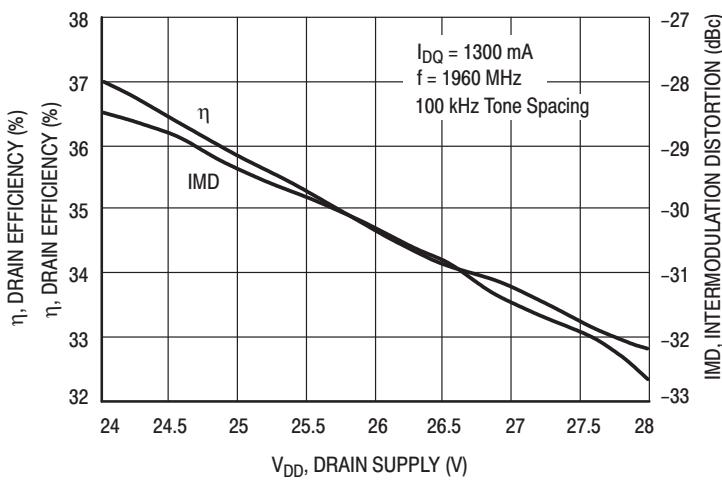
**Figure 5.** Third Order Intermodulation Distortion versus Output Power



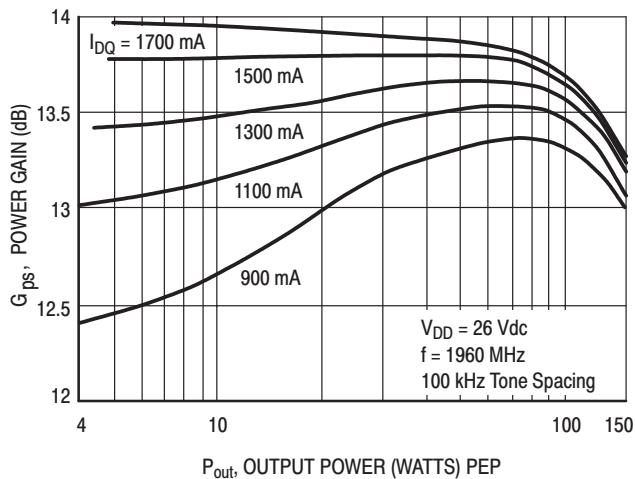
**Figure 6.** 2-Carrier N-CDMA Broadband Performance



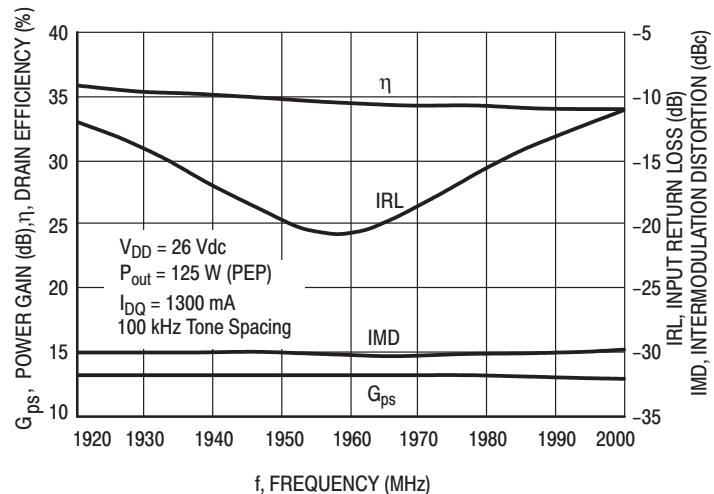
**Figure 7.** CW Performance



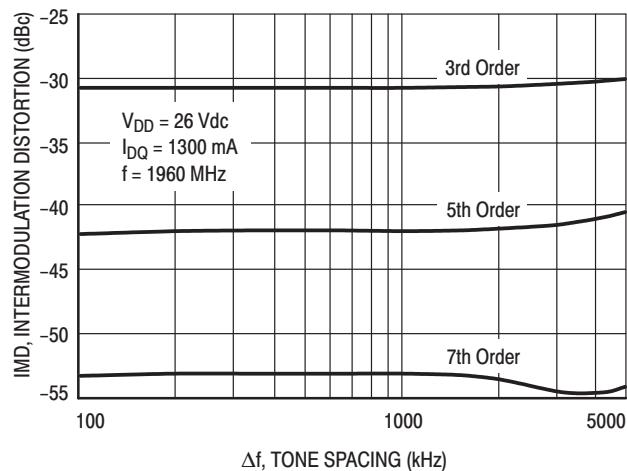
**Figure 8.** Two-Tone Intermodulation Distortion and Drain Efficiency versus Drain Supply



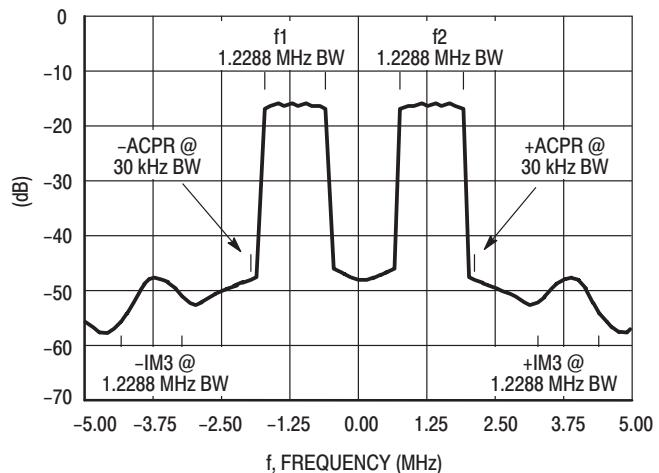
**Figure 9. Two-Tone Power Gain versus Output Power**



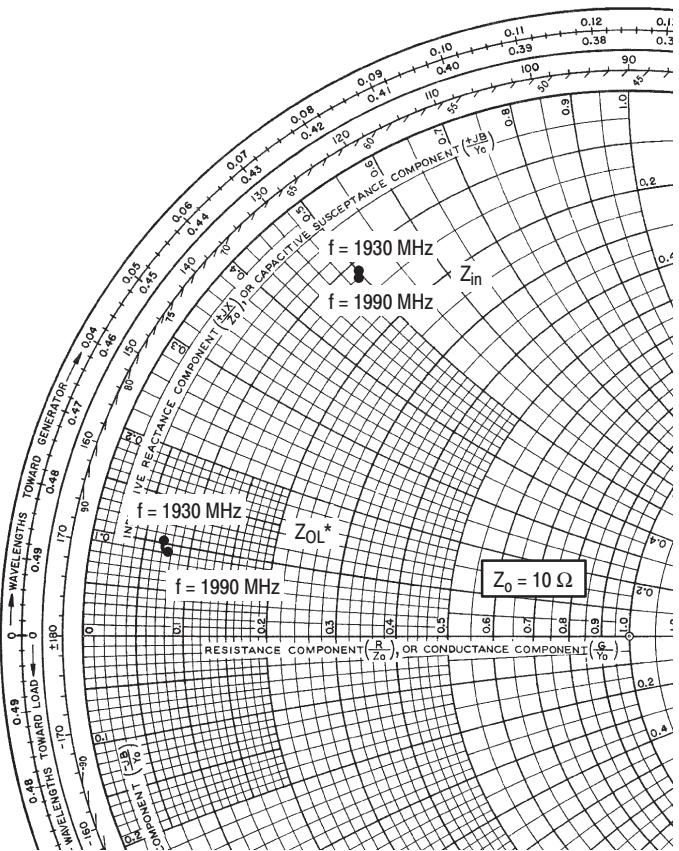
**Figure 10. Two-Tone Broadband Performance**



**Figure 11. Intermodulation Distortion Products versus Two-Tone Tone Spacing**



**Figure 12. 2-Carrier N-CDMA Spectrum**



$V_{DD} = 26 \text{ V}$ ,  $I_{DQ} = 1300 \text{ mA}$ ,  $P_{out} = 24 \text{ W}$  (Avg.)

$f$ MHz	$Z_{in}$ $\Omega$	$Z_{OL^*}$ $\Omega$
1930	$1.43 + j5.01$	$0.75 + j0.93$
1960	$1.51 + j4.88$	$0.71 + j0.89$
1990	$1.56 + j4.93$	$0.68 + j1.02$

$Z_{in}$  = Complex conjugate of source impedance.

$Z_{OL^*}$  = Complex conjugate of the optimum load impedance at a given output power, voltage, IMD, bias current and frequency.

Note:  $Z_{OL^*}$  was chosen based on tradeoffs between gain, output power, drain efficiency and intermodulation distortion.

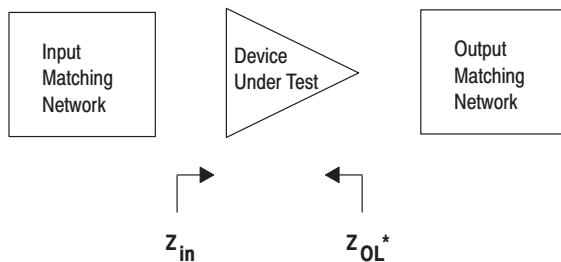
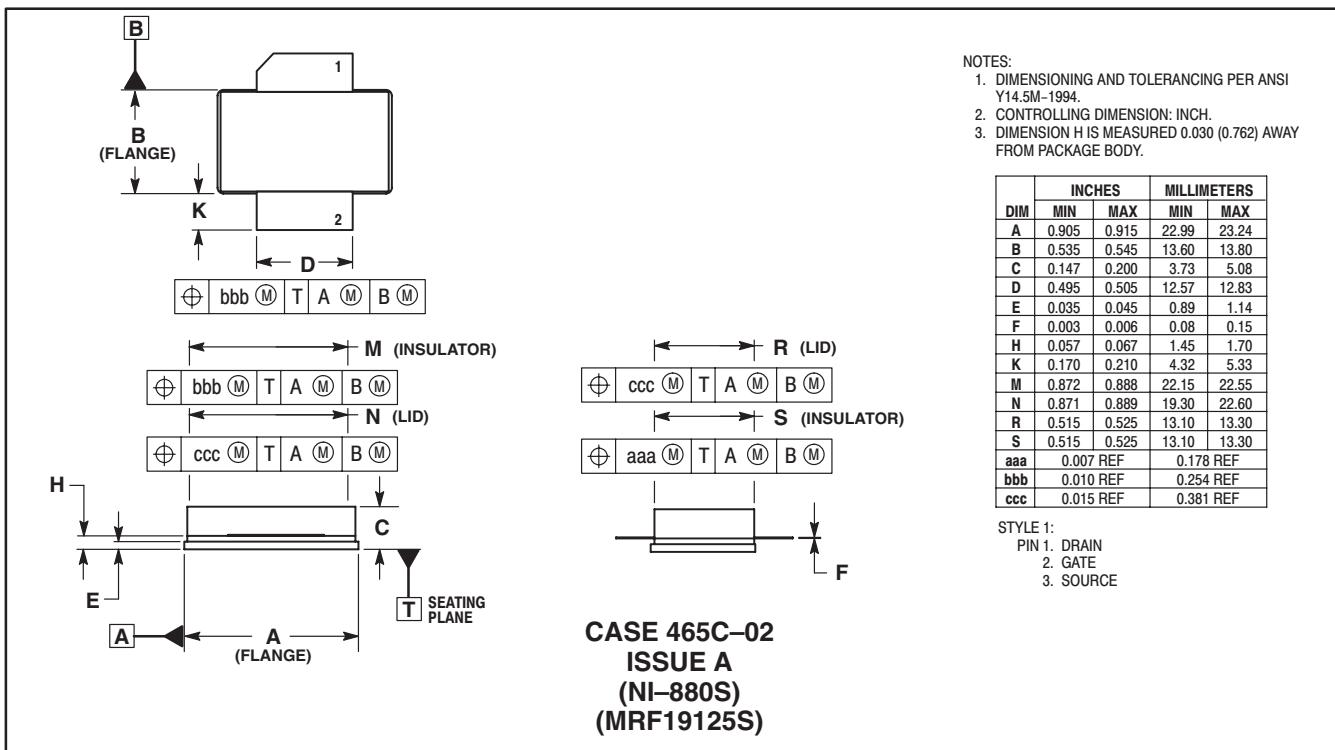
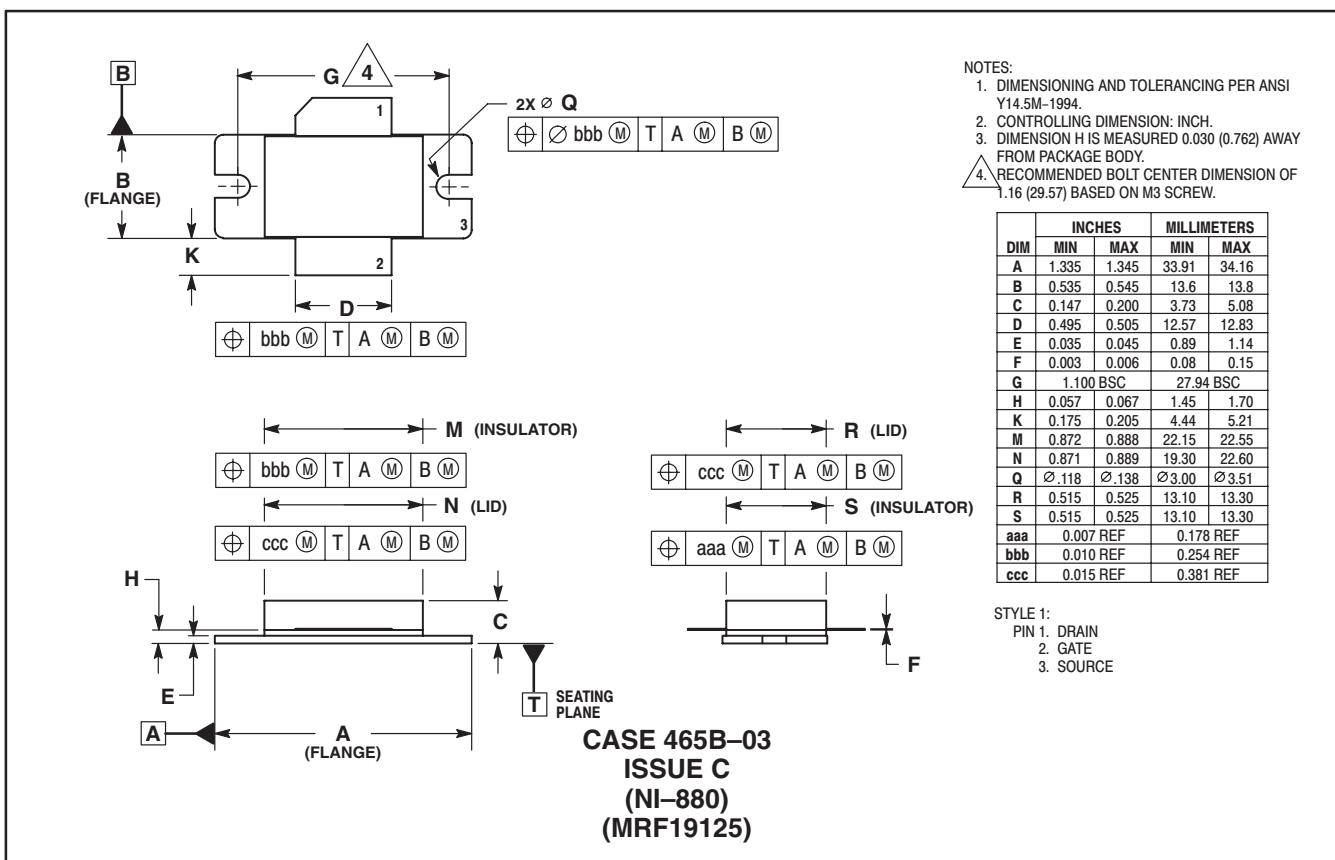


Figure 13. Series Equivalent Input and Output Impedance

## **NOTES**

# **NOTES**

## PACKAGE DIMENSIONS



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